



WEBINARS



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Advanced Motion Control for Semiconductor Metrology

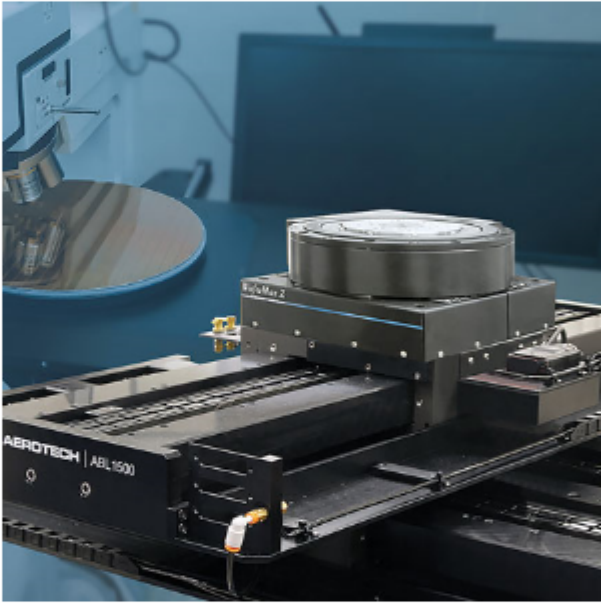
Thursday, October 16, 2025 1:00 PM - 2:00 PM EDT

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Presented by



Join our webinar on advanced motion control for semiconductor inspection and metrology. Discover how precision motion systems enable cutting-edge applications like wafer inspection, SWLI, SEM/FIB, and AFM. Learn about compensating for error motions, system-level optimization, and advanced control techniques to achieve nanometer-level precision and maximize throughput. Explore industry-leading solutions pushing the boundaries of semiconductor metrology. This webinar is ideal for anyone in the semiconductor industry seeking to enhance accuracy, speed, and reliability in their manufacturing operations. Presented by [Aerotech](#).



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